

Notice of References Cited

Application/Control No.

10/711,738

Applicant(s)/Patent Under

Reexamination

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Examiner

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Art Unit

2185

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,787,497	07-1998	Tokura et al.	711/220
*	B	US-5,623,621	04-1997	Garde, Douglas	711/220
*	C	US-5,765,187	06-1998	Shimizu et al.	711/110
*	D	US-4,169,289	09-1979	Shively, Richard R.	710/56
*	E	US-6,397,318	05-2002	Peh, Kheng Boon	711/220
*	F	US-6,112,266	08-2000	Yeh, Han C.	710/52
*	G	US-6,044,434	03-2000	Oliver, Richard J.	711/110
*	H	US-6,021,133	02-2000	Asghar, Saf	370/429
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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